



# SSC8037GS1

## P-Channel Enhancement Mode MOSFET

### ➤ Features

VDS	VGS	RDSON Typ.	ID
-30V	±25V	15mR@-10V	-34A
		23mR@-4V5	

### ➤ Description

This device is produced with high cell density DMOS trench technology, uses advanced trench technology and design to provide excellent RDSON with low gate charge. This device particularly suits low voltage applications such as portable equipment, power management and other battery powered circuits, and low in-line power dissipation are needed in a very small outline surface mount package.

**100% UIS Tested.**

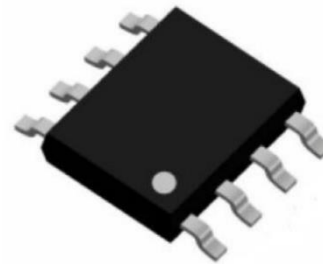
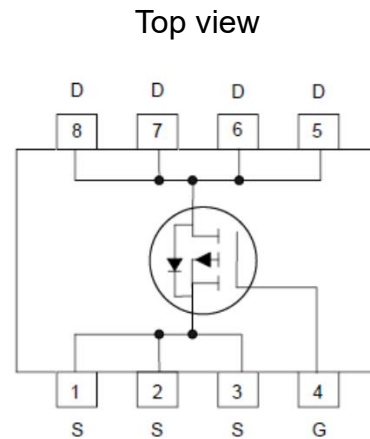
### ➤ Applications

- Load Switch
- NB battery
- DCDC conversion

### ➤ Ordering Information

Device	Package	Shipping
SSC8037GS1	SOP8	4000/Reel

### ➤ Pin configuration



Bottom View



(Y: year/W: week)

Marking

➤ **Absolute Maximum Ratings**( $T_A=25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
$V_{DSS}$	Drain-to-Source Voltage	-30	V	
$V_{GSS}$	Gate-to-Source Voltage	$\pm 25$	V	
$I_D$	Continuous Drain Current <sup>d</sup>	TC=25 $^{\circ}\text{C}$	-34	A
		TC=100 $^{\circ}\text{C}$	-19	
$I_{DSM}$	Continuous Drain Current <sup>a</sup>	TA=25 $^{\circ}\text{C}$	-10.7	A
		TA=70 $^{\circ}\text{C}$	-7.8	
$I_{DM}$	Pulsed Drain Current <sup>b</sup>	-136	A	
$I_{AS}$	Avalanche Current <sup>b</sup> L=0.5mH	-21	A	
$E_{AS}$	Avalanche Energy <sup>b</sup> L=0.5mH	110	mJ	
$P_D$	Power Dissipation <sup>d</sup>	TC=25 $^{\circ}\text{C}$	28	W
		TC=100 $^{\circ}\text{C}$	11	W
$P_{DSM}$	Power Dissipation <sup>a</sup>	TA=25 $^{\circ}\text{C}$	2.8	W
		TA=70 $^{\circ}\text{C}$	1.8	W
$T_J$	Operation junction temperature	-55 to 150	$^{\circ}\text{C}$	
$T_{STG}$	Storage temperature range	-55 to 150		

➤ **Thermal Resistance Ratings**( $T_A=25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance <sup>a</sup>	45	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case Thermal Resistance <sup>c</sup>	22	
	Junction-to-Case Thermal Resistance <sup>d</sup>	4.4	

Note:

- The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper,in a still air environment with  $T_A=25^{\circ}\text{C}$ .The value in any given application depends on the user is specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.
- Repetitive rating, pulse width limited by junction temperature.
- The power dissipation  $P_D$  is based on  $T_J(\text{MAX})=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- The value of  $R_{\theta JC}$  has been determined of the temperature difference between junction and the case surface in contact with water cooled copper heat sink .

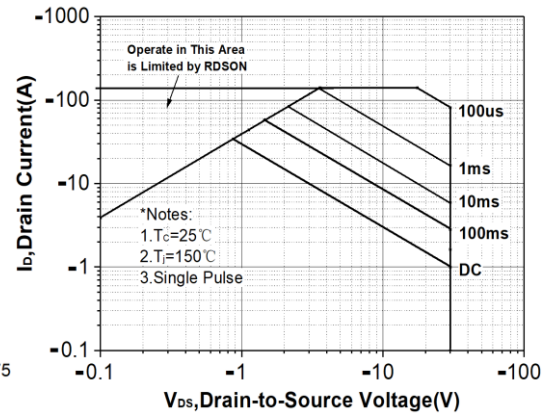
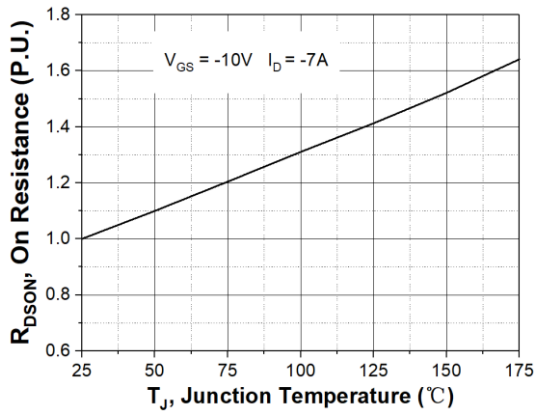
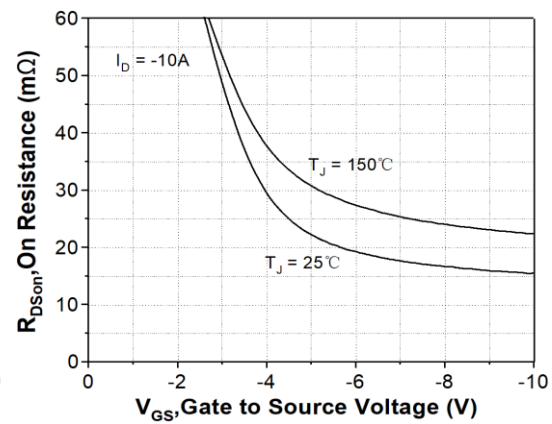
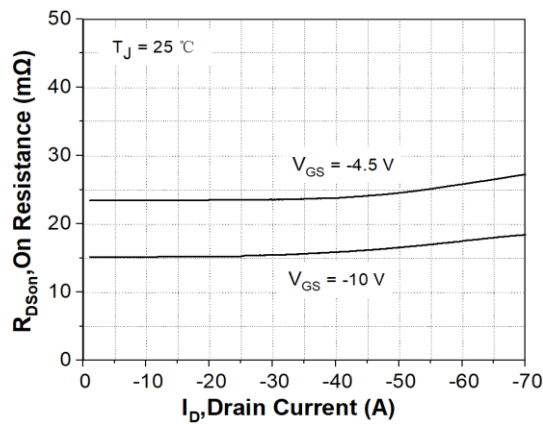
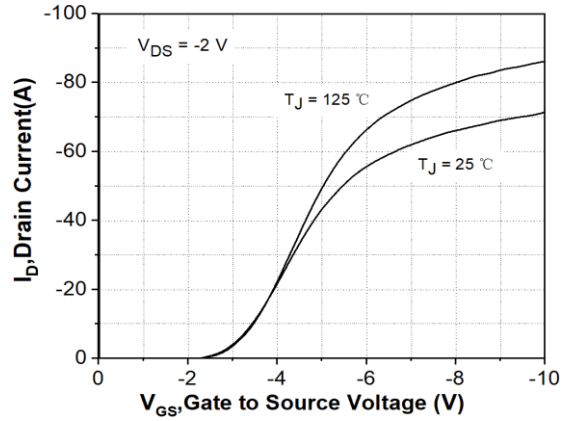
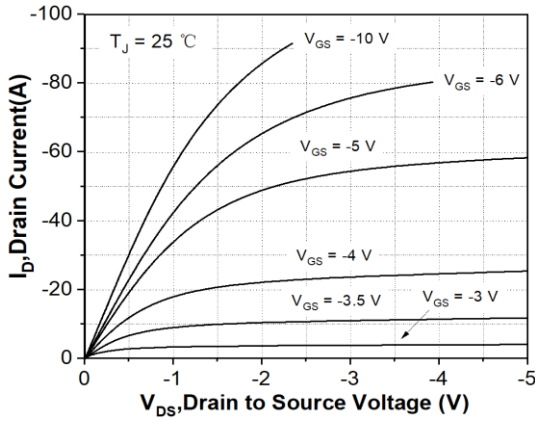


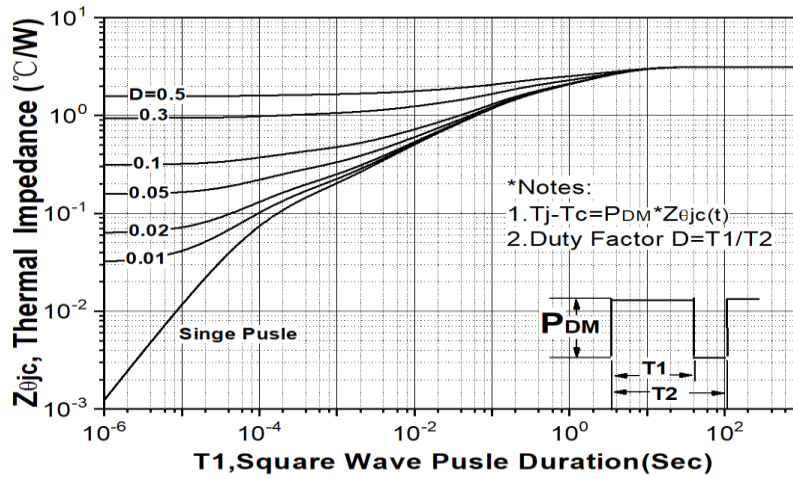
➤ **Electronics Characteristics**( $T_A=25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Unit
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1	-1.6	-3	V
$R_{DS(on)}$	Drain-Source On-Resistance	$V_{GS}=-10V, I_D=-10A$		15	19	mR
		$V_{GS}=-4.5V, I_D=-7A$		23	30	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-30V, V_{GS}=0V$			-1	$\mu A$
$I_{GSS}$	Gate-Source leak current	$V_{GS}=\pm 25V, V_{DS}=0V$			$\pm 100$	nA
$G_{FS}$	Transconductance	$V_{DS}=-5V, I_D=-5A$		11		S
$V_{SD}$	Forward Voltage	$V_{GS}=0V, I_S=-5A$		-0.8	-1.3	V
$C_{iss}$	Input Capacitance	$V_{DS}=-15V, V_{GS}=0V, f=1MHz$		1300		pF
$C_{oss}$	Output Capacitance			161		
$C_{rss}$	Reverse Transfer Capacitance			183		
$Q_G$	Total Gate charge	$V_{GS}=-10V, V_{DS}=-15V, I_D=-10A$		25.5		nC
$Q_{GS}$	Gate to Source charge			4.3		
$Q_{GD}$	Gate to Drain charge			6.1		
$T_{D(ON)}$	Turn-on delay time	$V_{GS}=-10V, V_{DS}=-15V, R_L=1R, R_G=3R$		8		ns
$T_r$	Rise time			33.5		
$T_{D(OFF)}$	Turn-off delay time			48		
$T_f$	Fall time			11		
$T_{rr}$	Diode Recovery Time	$I_F=-10A, di/dt=200A/\mu s$		23		ns
$Q_{rr}$	Diode Recovery Charge			8		nC

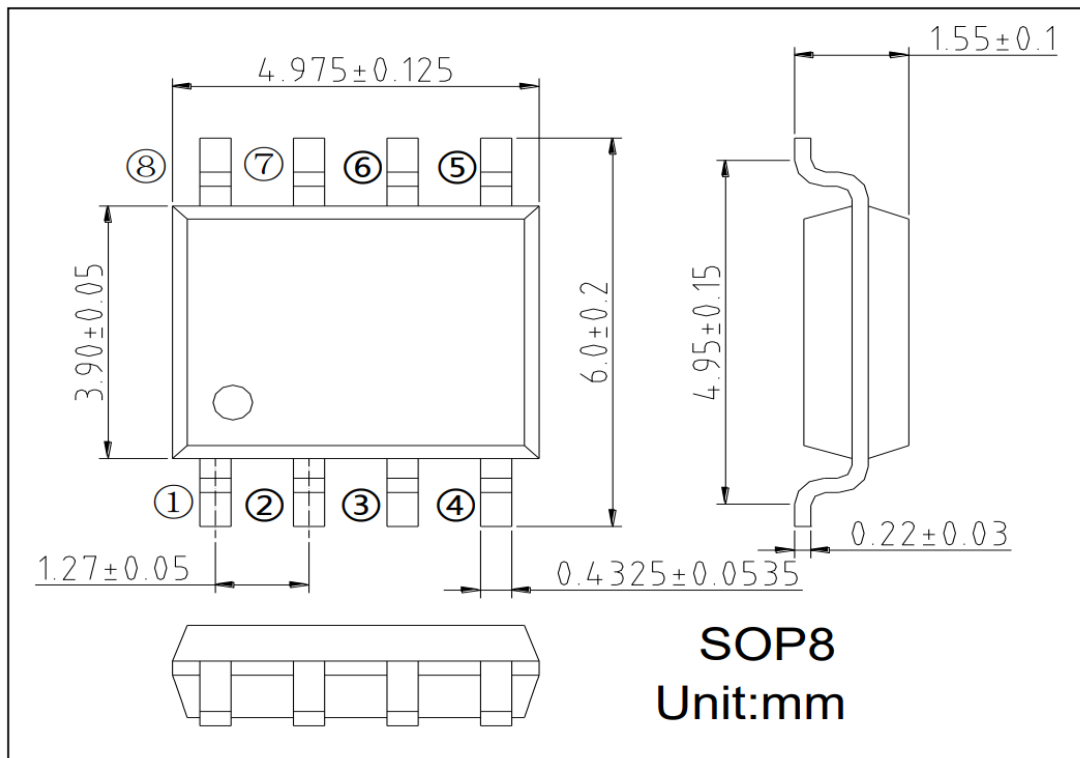


➤ Typical Characteristics ( $T_A=25^\circ\text{C}$  unless otherwise noted)





➤ Package Information





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